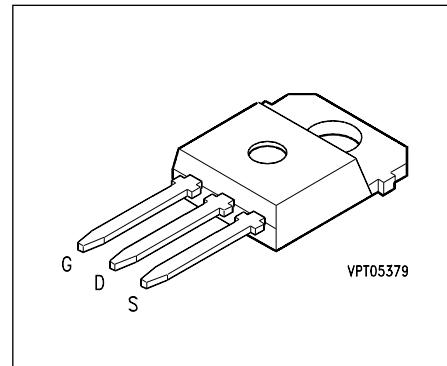


## SIPMOS® Power Transistor

**BUZ 341**

- N channel
- Enhancement mode
- Avalanche-rated



Type	$V_{DS}$	$I_D$	$R_{DS\ (on)}$	Package <sup>1)</sup>	Ordering Code
BUZ 341	200 V	33 A	0.07 Ω	TO-218 AA	C67078-S3128-A2

### Maximum Ratings

Parameter	Symbol	Values	Unit
Continuous drain current, $T_C = 28^\circ\text{C}$	$I_D$	33	A
Pulsed drain current, $T_C = 25^\circ\text{C}$	$I_{D\ puls}$	132	
Avalanche current, limited by $T_{j\ max}$	$I_{AR}$	33	
Avalanche energy, periodic limited by $T_{j\ (max)}$	$E_{AR}$	16	mJ
Avalanche energy, single pulse $I_D = 33\text{ A}$ , $V_{DD} = 50\text{ V}$ , $R_{GS} = 25\text{ }\Omega$ $L = 1.09\text{ mH}$ , $T_j = 25^\circ\text{C}$	$E_{AS}$	790	
Gate-source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation, $T_C = 25^\circ\text{C}$	$P_{tot}$	170	W
Operating and storage temperature range	$T_j$ , $T_{stg}$	-55 ... +150	°C

Thermal resistance, chip-case	$R_{th\ JC}$	$\leq 0.74$	K/W
DIN humidity category, DIN 40 040	-	E	-
IEC climatic category, DIN IEC 68-1	-	55/150/56	

1) See chapter Package Outlines.

**Electrical Characteristics**at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Static characteristics**

Drain-source breakdown voltage $V_{GS} = 0 \text{ V}, I_D = 0.25 \text{ mA}$	$V_{(BR) DSS}$	200	–	–	V
Gate threshold voltage $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	$V_{GS (\text{th})}$	2.1	3.0	4.0	
Zero gate voltage drain current $V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	$I_{DSS}$	–	0.1	1.0	$\mu\text{A}$
–	–	–	10	100	
Gate-source leakage current $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	$I_{GSS}$	–	10	100	nA
Drain-source on-resistance $V_{GS} = 10 \text{ V}, I_D = 21 \text{ A}$	$R_{DS (\text{on})}$	–	0.06	0.07	$\Omega$

**Dynamic characteristics**

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}, I_D = 21 \text{ A}$	$g_{fs}$	15	23	–	S
Input capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{iss}$	–	2600	3900	pF
Output capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{oss}$	–	500	750	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{rss}$	–	230	350	
Turn-on time $t_{on}$ , ( $t_{on} = t_{d(on)} + t_r$ ) $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_{GS} = 50 \Omega$	$t_{d(on)}$	–	40	60	ns
	$t_r$	–	110	170	
Turn-off time $t_{off}$ , ( $t_{off} = t_{d(off)} + t_f$ ) $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_{GS} = 50 \Omega$	$t_{d(off)}$	–	450	680	
	$t_f$	–	160	240	

**Electrical Characteristics** (cont'd)  
at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

<b>Parameter</b>	<b>Symbol</b>	<b>Values</b>			<b>Unit</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>	

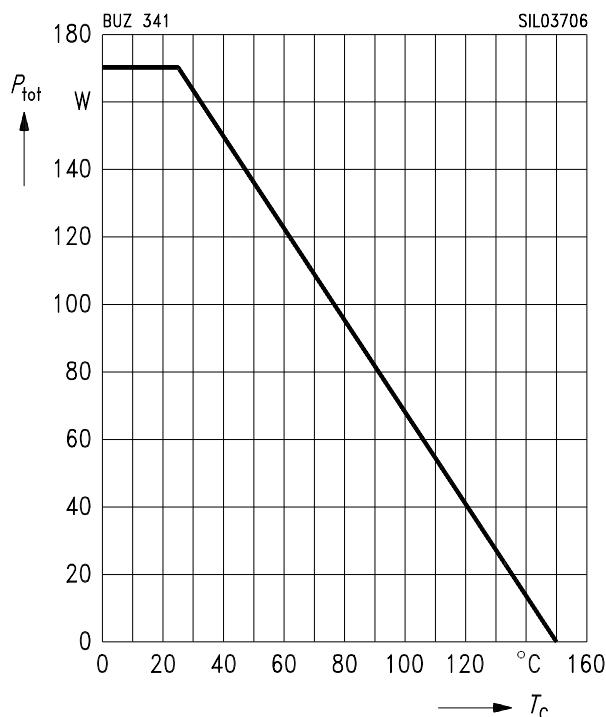
#### Reverse diode

Continuous reverse drain current $T_C = 25^\circ\text{C}$	$I_S$	—	—	33	A
Pulsed reverse drain current $T_C = 25^\circ\text{C}$	$I_{SM}$	—	—	132	
Diode forward on-voltage $I_S = 66 \text{ A}, V_{GS} = 0 \text{ V}$	$V_{SD}$	—	1.3	1.6	V
Reverse recovery time $V_R = 30 \text{ V}, I_F = I_S, di_F / dt = 100 \text{ A}/\mu\text{s}$	$t_{rr}$	—	230	—	ns
Reverse recovery charge $V_R = 30 \text{ V}, I_F = I_S, di_F / dt = 100 \text{ A}/\mu\text{s}$	$Q_{rr}$	—	1.8	—	$\mu\text{C}$

**Characteristics** at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

### Total power dissipation

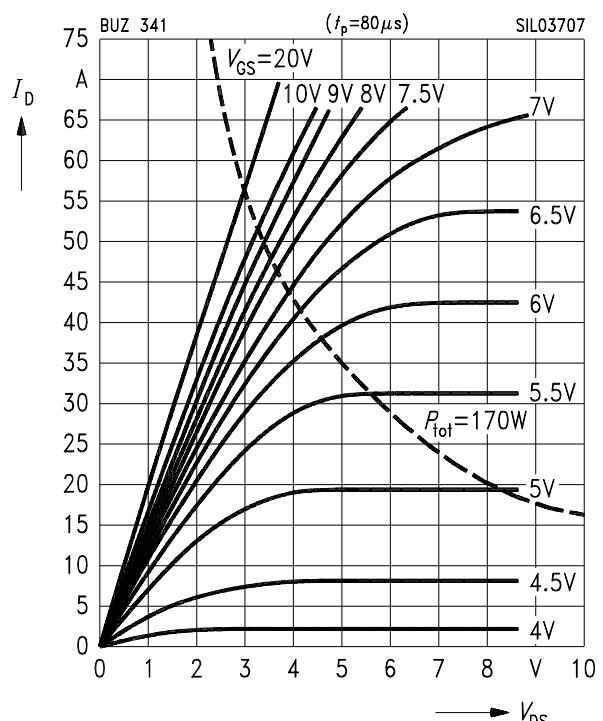
$$P_{\text{tot}} = f(T_C)$$



### Typ. output characteristics

$$I_D = f(V_{DS})$$

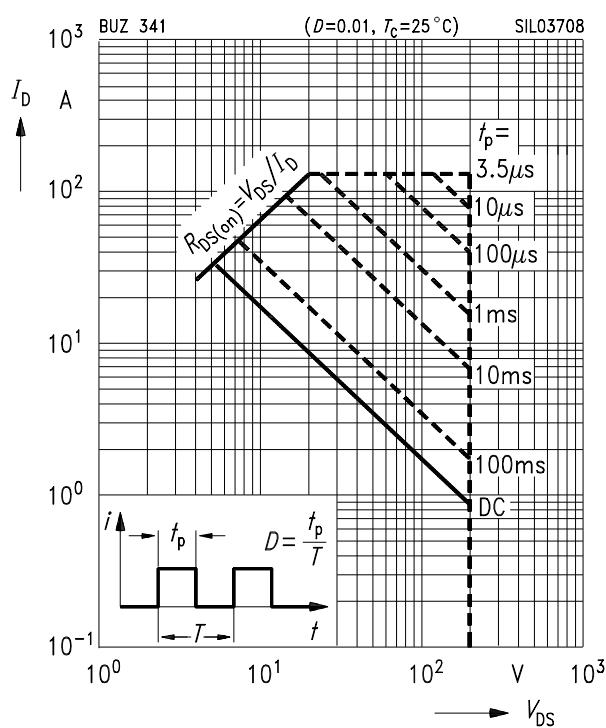
parameter:  $t_p = 80 \mu\text{s}$



### Safe operating area

$$I_D = f(V_{DS})$$

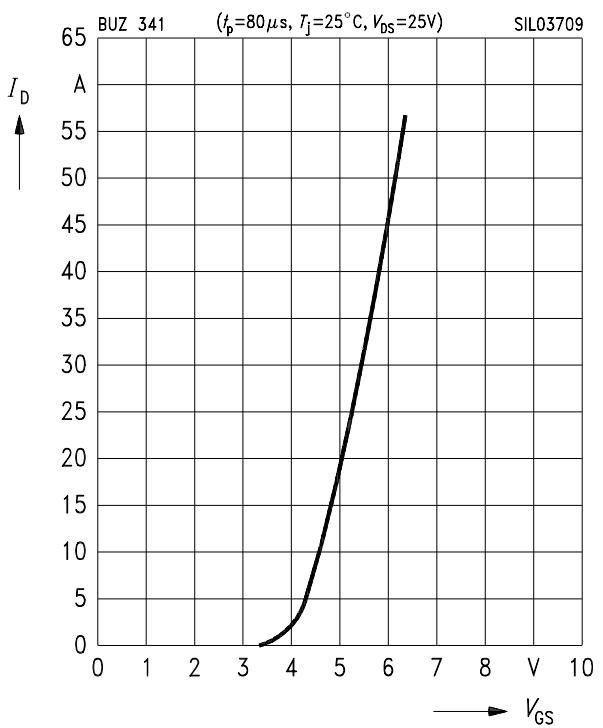
parameter:  $D = 0.01$ ,  $T_C = 25^\circ\text{C}$



### Typ. transfer characteristics

$$I_D = f(V_{GS})$$

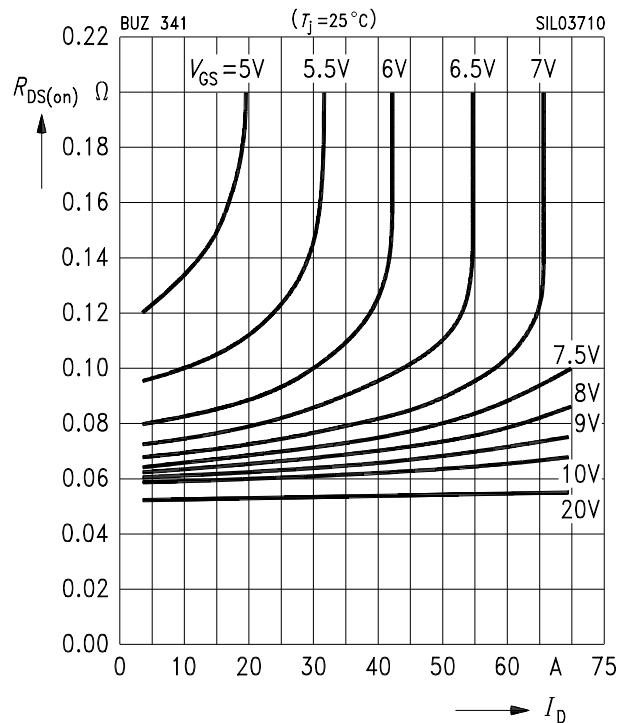
parameter:  $t_p = 80 \mu\text{s}$ ,  $V_{DS} = 25 \text{ V}$



## Typ. drain-source on-resistance

$$R_{DS(on)} = f(I_D)$$

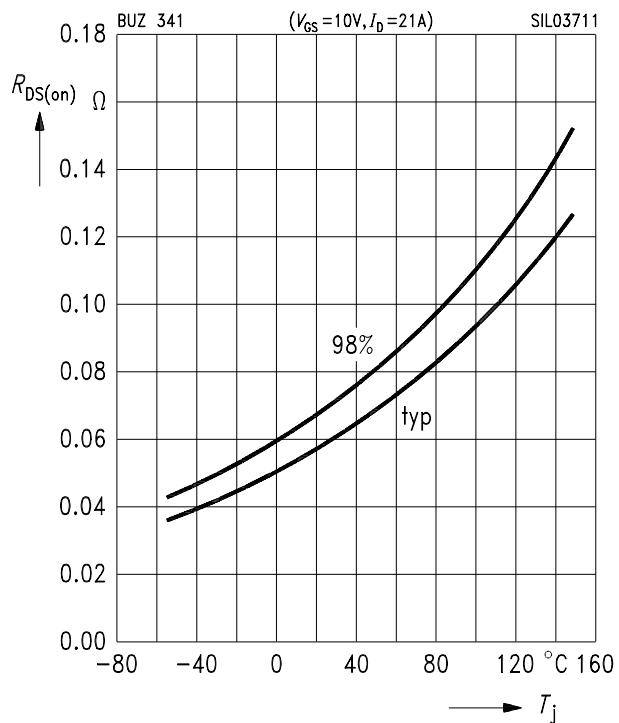
parameter:  $V_{GS}$



## Drain-source on-resistance

$$R_{DS(on)} = f(T_j)$$

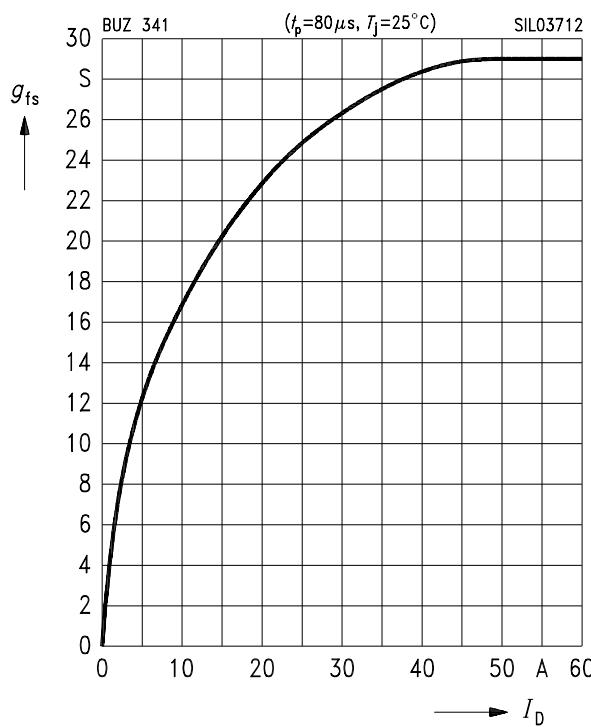
parameter:  $I_D = 21 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$ , (spread)



## Typ.forward transconductance

$$g_{fs} = f(I_D)$$

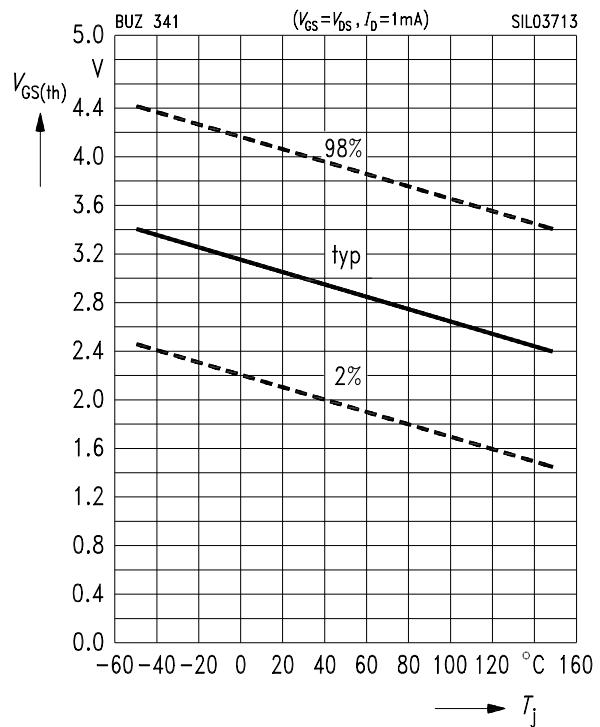
parameter:  $t_p = 80 \mu\text{s}$



## Gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

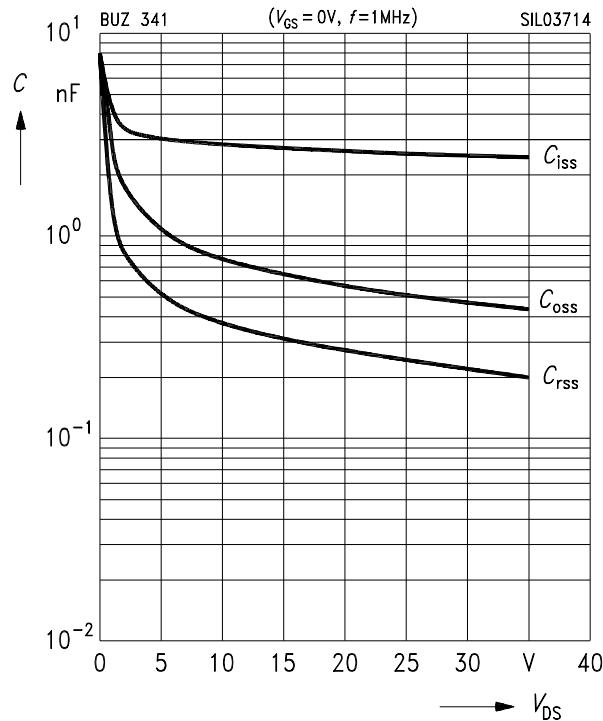
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 1 \text{ mA}$ , (spread)



### Typ. capacitances

$$C = f(V_{DS})$$

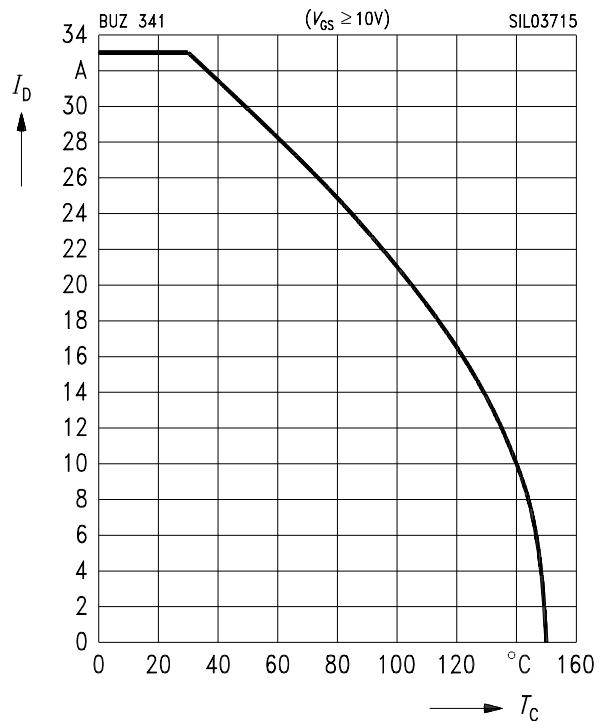
parameter:  $V_{GS} = 0 \text{ V}$ ,  $f = 1 \text{ MHz}$



### Drain current

$$I_D = f(T_C)$$

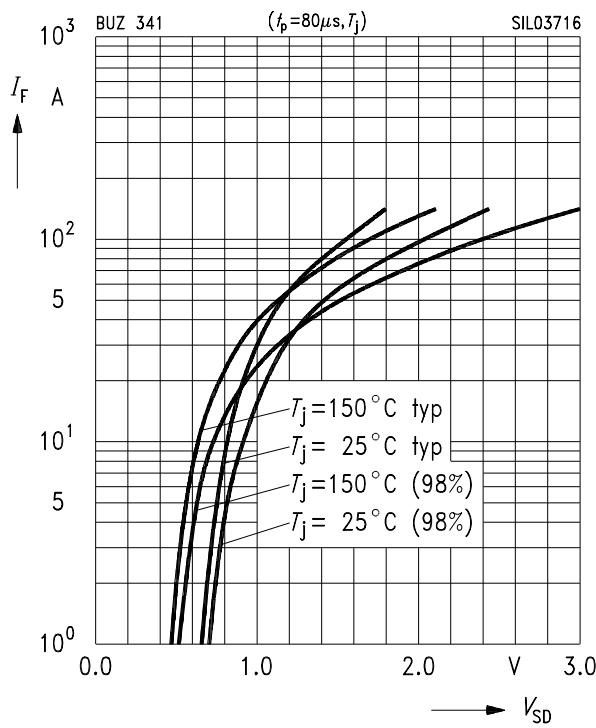
parameter:  $V_{GS} \geq 10 \text{ V}$



### Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

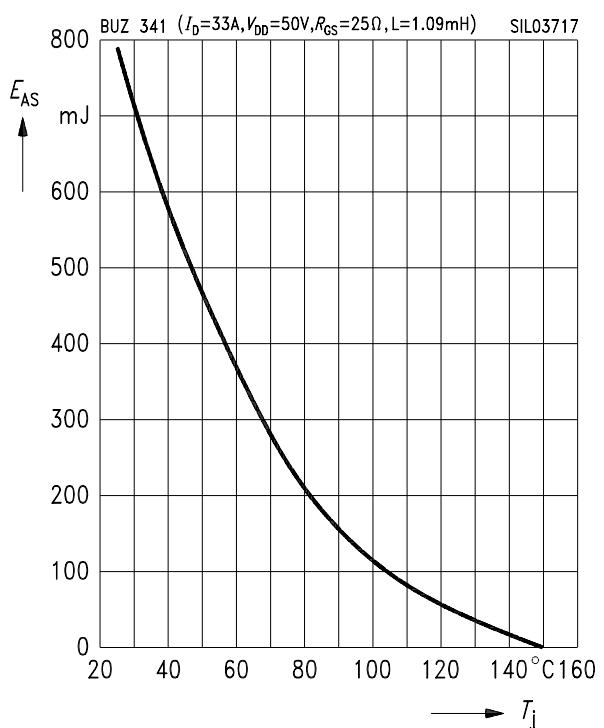
parameter:  $t_p = 80 \mu\text{s}$ ,  $T_j$



### Avalanche energy $E_{AS} = f(T_j)$

parameter:  $I_D = 33 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$

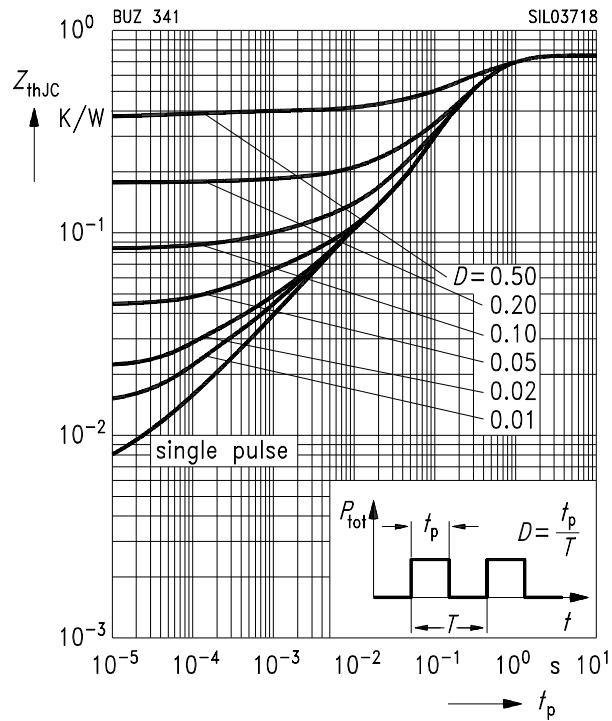
$R_{GS} = 25 \Omega$ ,  $L = 1.09 \text{ mH}$



## Transient thermal impedance

$$Z_{thJC} = f(t_p)$$

parameter:  $D = t_p / T$



## Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

parameter:  $I_{D\ puls} = 49.5$  A

